

N-Channel Enhancement Mode Power MOSFET

General Description

The series of Power MOSFETs use advanced technology and design. This high voltage MOSFET fits Switched applications.

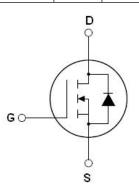
Features

- High speed switching
- ●Intrinsic capacitances and Qg minimized
- ●100% Avalanche Tested

Ap	nl	ica	tic	าท
76	PI	U		<i>,</i> ,,

Switched applications

V _{DS min@Tjmax}	1650	V	
R _{DS(ON)TYP}	5.5	Ω	
ID	3	Α	
Qg	32	nC	



Schematic diagram

Package Marking And Ordering Information

Device	Device Package	Marking	
NCE3N150PF	TO-3PF	NCE3N150PF	



TO-3PF

Table 1. Absolute Maximum Ratings (T_C=25℃)

Parameter	Symbol	NCE3N150PF	Unit
Drain-Source Voltage (VGS=0V)	VDS	1500	V
Gate-Source Voltage (VDS=0V) DC	Vgs	±30	V
Continuous Drain Current at Tc=25°C	I _{D (DC)}	3	А
Continuous Drain Current at Tc=100°C	I _{D (DC)}	2.10	А
Pulsed drain current (Note 1)	I _{DM (pluse)}	9	А
Maximum Power Dissipation(Tc=25°C)	P _D	88	W
Derate above 25°C		0.58	W/°C
Single pulse avalanche energy (Note 2)	Eas	225	mJ
Single pulse avalanche current (Note 2)	I _{AS}	3	А
Operating Junction and Storage Temperature Range	T _J ,T _{STG}	-55+175	°C

^{*} limited by maximum junction temperature



Table 2. Thermal Characteristic

Parameter	Symbol	NCE3N150	Unit
Thermal Resistance, Junction-to-Case (Maximum)	R _{thJC}	1.7	°C /W
Thermal Resistance, Junction-to-Ambient (Maximum)	R _{thJA}	50	°C /W

Table 3. Electrical Characteristics (TA=25°Cunless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
On/off states						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =1mA	1500			V
Zero Gate Voltage Drain Current(Tc=25℃)	I _{DSS}	V _{DS} =1500V,V _{GS} =0V			1	μA
Zero Gate Voltage Drain Current(Tc=125℃)	IDSS	V _{DS} =1500V,V _{GS} =0V			100	μA
Gate-Body Leakage Current	Igss	V _{GS} =±30V,V _{DS} =0V			±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V _{DS} =V _{GS} ,I _D =250µA	3	4	5	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =1.5A		5.5	7.5	Ω
Dynamic Characteristics						
Input Capacitance	C _{lss}	10111		1700		pF
Output Capacitance	Coss	V_{DS} =40V, V_{GS} =0V, F=1.0MHz		61		pF
Reverse Transfer Capacitance	C _{rss}	F=1.0IVIH2		5.5		pF
Total Gate Charge	Qg	\/ 4000\/1 4.54		32		nC
Gate-Source Charge	Q _{gs}	V_{DS} =1200V, I_{D} =1.5A, V_{GS} =10V		8.7		nC
Gate-Drain Charge	Q_{gd}	VGS=1UV		12		nC
Intrinsic gate resistance	R _G	f = 1 MHz open drain		2		Ω
Switching times						
Turn-on Delay Time	t _{d(on)}			22		nS
Turn-on Rise Time	tr	V_{DD} =750 V , I_{D} =1.5 A ,		45		nS
Turn-Off Delay Time	t _{d(off)}	$R_G=3\Omega, V_{GS}=10V$		42		nS
Turn-Off Fall Time	t _f			58		nS
Source- Drain Diode Characteristics						
Source-drain current(Body Diode)	Isp	T -25°C			3	А
Pulsed Source-drain current(Body Diode)	Isdm	T _C =25°C			9	Α
Forward On Voltage	V _{SD}	Tj=25°C,I _{SD} =3A,V _{GS} =0V 0.8		0.8	1.1	V
Reverse Recovery Time	t _{rr}	T:-05°C 0A		390		nS
Reverse Recovery Charge	Qrr	Tj=25°C,I _F =3A,		2.2		uC
Peak Reverse Recovery Current	I _{rrm}	di/dt=100A/µs		11		Α

Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature

2. Tj=25 $^{\circ}$ C,VDD=50V,VG=10V, R_G=25 Ω



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (curves)

Figure 1. Safe operating area

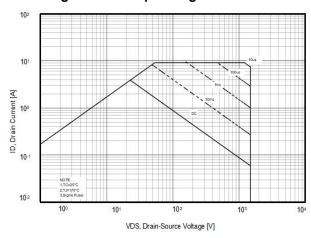


Figure 2. Source-Drain Diode Forward Voltage

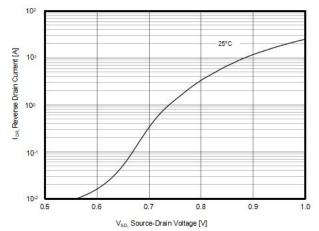


Figure 3. R_{DS(ON)} vs Junction Temperature

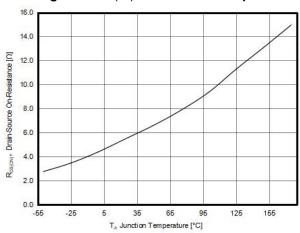


Figure 4. BV_{DSS} vs Junction Temperature

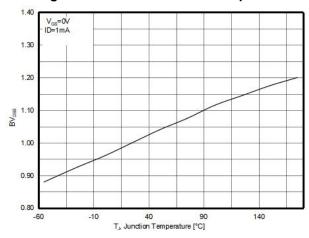


Figure 5. Maximum ID vs Junction Temperature

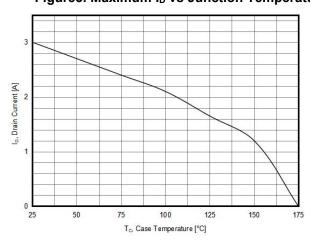


Figure 6. Output characteristics

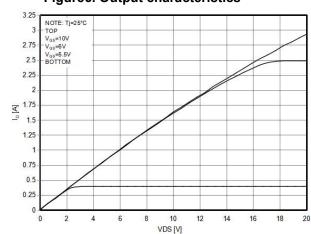






Figure7. Capacitance

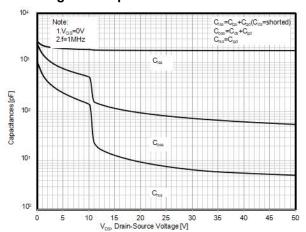


Figure 8. Transfer characteristics

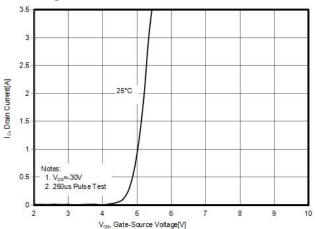
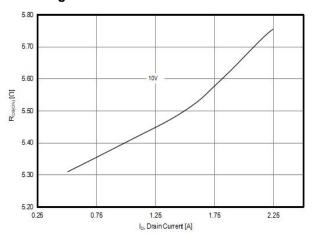
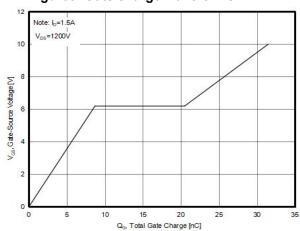


Figure 9. Static drain-source on resistance



Wuxi NCE Power Co., Ltd

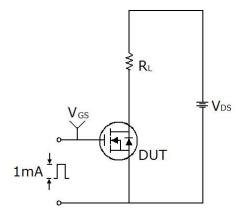
Figure 9. Gate charge waveforms

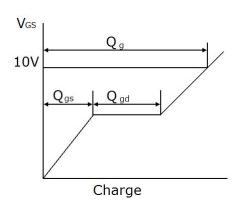




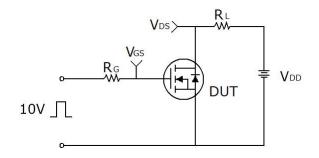
Test circuit

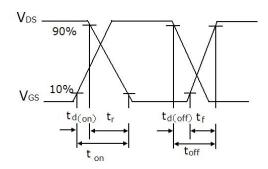
1) Gate charge test circuit & Waveform



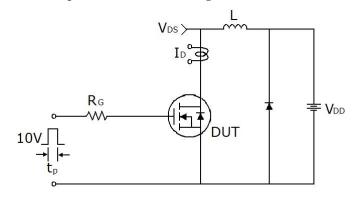


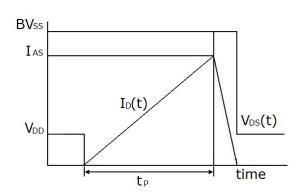
2) Switch Time Test Circuit:





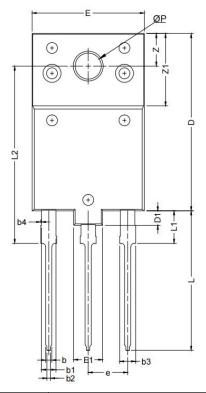
3) Unclamped Inductive Switching Test Circuit & Waveforms

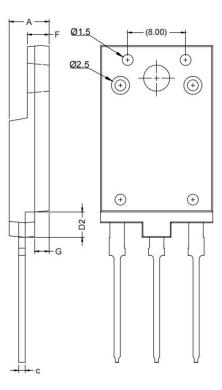






TO-3PF-B Package Information





Symbol	Dimensions	In Millimeters	Dimension	s In Inches	
Symbol	Min.	Max.	Min.	Max.	
А	5.300	5.700	0.209	0.224	
b	0.650	0.950	0.026	0.037	
b4		0.200		0.008	
С	0.800	1.000	0.031	0.039	
D	24.200	24.800	0.953	0.976	
D1	1.800	2.200	0.071	0.087	
D2	3.300	3.700	0.130	0.146	
E	15.300	15.700	0.602	0.618	
E1	3.800	4.200	0.150	0.165	
F	2.800	3.200	0.110	0.126	
е	5.450	5.450 BSC		0.215 BSC	
L	19.000	19.600	0.748	0.772	
L1	4.200	4.800	0.165	0.189	
L2	24.200	24.800	0.953	0.976	
Р	3.400	3.800	0.134	0.150	
Z	4.300	4.700	0.169	0.185	
Z1	9.700	10.300	0.382	0.406	
G	1.800	2.200	0.071	0.087	
S	3.100	3.500	0.122	0.138	



ATTENTION:

- Any and all NCE products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your NCE representative nearest you before using any NCE products described or contained herein in such applications.
- NCE assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all NCE products described or contained herein.
- Specifications of any and all NCE products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- NCE Power Semiconductor CO.,LTD. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- In the event that any or all NCE products(including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of NCE Power Semiconductor CO.,LTD.
- Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. NCE believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the NCE product that you intend to use.
- This catalog provides information as of Mar. 2010. Specifications and information herein are subject to change without notice.